

UNISONIC TECHNOLOGIES CO., LTD

L6134

Preliminary

LINEAR INTEGRATED CIRCUIT

LOW POWER 10 MHZ **RAIL-TO-RAIL I/O QUAD OPERATIONAL AMPLIFIERS**

DESCRIPTION

The UTC L6134 provides new levels of speed vs power performance in applications where low voltage supplies or power limitations previously made compromise necessary. With only 350µA/amp supply current, the 10MHz gain-bandwidth of this device supports new portable applications where higher power devices unacceptably drain battery life.

The UTC L6134 can be driven by voltages that exceed both power supply rails, thus eliminating concerns over exceeding the common-mode voltage range. The rail-to-rail output swing capability provides the maximum possible dynamic range at the output. This is particularly important when operating on low supply voltages. The UTC L6134 can also drive large capacitive loads without oscillating.

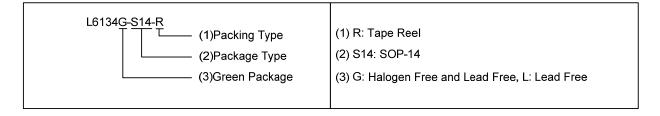
Operating on supplies from 2.7V to over 24V, the UTC L6134 is excellent for a very wide range of applications, from battery operated systems with large bandwidth requirements to high speed instrumentation.

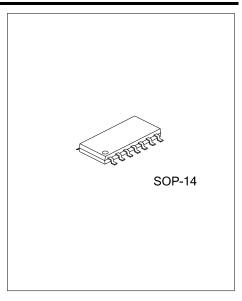
FEATURES

- * (For 5V Supply, Typ. Unless Noted)
- * Rail-to-rail Input : -0.25V ~ 5.25V
- * Rail-to-Rail Output : 0.01V ~ 4.99V
- * High Gain-Bandwidth, 10MHz at 20kHz
- * Slew Rate 12V/µs
- * Low Supply Current 350µA/Amplifier
- * Wide Supply Range: 2.7V ~ 24V
- * Gain 100dB with R_L=10k

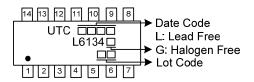
ORDERING INFORMATION

Ordering	Package	Dooking	
Lead Free	Lead Free Halogen Free		Packing
L6134L-S14-R	L6134G-S14-R	SOP-14	Tape Reel

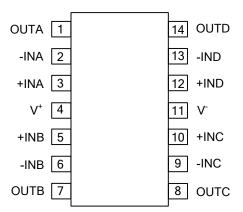




MARKING



PIN CONFIGURATION



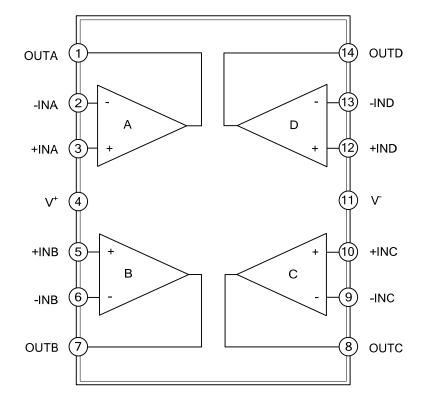
■ PIN DESCRIPTION

PIN NO.	PIN NAME	I/O	DESCRIPTION
1	OUTA	0	Analog Output pin of A AMP
2	-INA	I	Inverting Input pin of A AMP
3	+INA	I	Non-inverting Input of A AMP
4	V ⁺	I	Positive Power Supply
5	+INB	I	Non-inverting Input of B AMP
6	-INB	I	Inverting Input pin of B AMP
7	OUTB	0	Analog Output pin of B AMP
8	OUTC	0	Analog Output pin of C AMP
9	-INC	I	Inverting Input pin of C AMP
10	+INC	I	Non-inverting Input of C AMP
11	V ⁻	I	Negative Power Supply
12	+IND	I	Non-inverting Input of D AMP
13	-IND	I	Inverting Input pin of D AMP
14	OUTD	0	Analog Output pin of D AMP



L6134

BLOCK DIAGRAM





■ ABSOLUTE MAXIMUM RATINGS (Note 1)

PARAMETER	SYMBOL	RATINGS	UNIT
Differential Input Voltage		±15	
Voltage at Input/Output Pin		(V ⁺) + 0.3, (V ⁻) - 0.3	V
Supply Voltage (V ⁺ - V⁻)		35	V
Current at Input Pin		±10	mA
Current at Output Pin (Note 2)		±25	mA
Current at Power Supply Pin		50	mA
Junction Temperature	TJ	+150	°C
Storage Temperature	T _{STG}	-65 ~ +150	°C

Notes: 1. Absolute maximum ratings are those values beyond which the device could be permanently damaged. Absolute maximum ratings are stress ratings only and functional device operation is not implied.

2. Applies to both single-supply and split-supply operation. Continuous short circuit operation at elevated ambient temperature can result in exceeding the maximum allowed junction temperature of 150°C.

RECOMMENDED OPERATING CONDITIONS

PARAMETER	SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT
Supply Voltage	V ⁺		2.7		24	V
Temperature Range	T _A		-40		+85	°C

5V DC ELECTRICAL CHARACTERISTICS (Note 1)

 $(V^+=5.0V, V^=0V, V_{CM}=V_0=V^+/2 \text{ and } R_L > 1M\Omega \text{ to } V^+/2, T_C=25^{\circ}C, \text{ unless otherwise specified})$

			peemea			
PARAMETER	SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT
	OTMBOL		(Note 3)	(Note 2)	(Note 3)	OTT
Input Offset Voltage	V _{OS}	T _A =25°C		4.0	8.0	mV
Innut Diag Cumant				110		nA
Input Bias Current	Ι _Β	$0V \le V_{CM} \le 5V$		180	350	nA
Input Offset Current	l _{os}			3	50	nA
Input Resistance, CM	R _{IN}			104		MΩ
Common Mode Dejection Datio	CMDD	$0V \le V_{CM} \le 4V$	70	100		dB
Common-Mode Rejection Ratio	CMRR	$0V \le V_{CM} \le 5V$	55	80		dB
Power Supply Rejection Ratio	PSRR	±2.5V ≤ V + ≤ ±12V	78	87		dB
Input Common-Mode Voltage	V	N	0	-0.25	5.0	V
Range	V _{CM}		0	~5.25		
Large Signal Voltage Gain	Av	R _L =10k	6	100		V/mV
	V _{он}	R _L =100k	4.93	4.98		V
		R _L =10k	4.85	4.94		V
Output Cuine		R _L =5k	4.85	4.9		V
Output Swing		R _L =100k		0.019	0.017	V
	V _{OL}	R _L =10k		0.07	0.09	V
		R _L =5k		0.095	0.12	V
		Sourcing	1	2		mA
Output Short Circuit Current	I _{SC}	Sinking	0.7	1.3		mA
Supply Current	ls	Per Amplifier		350	450	μA

Notes: 1. Electrical Table values apply only for factory testing conditions at the temperature indicated. Factory testing conditions result in very limited self-heating of the device such that $T_J=T_A$. No guarantee of parametric performance is indicated in the electrical tables under conditions of the internal self heating where $T_J > T_A$.

2. All voltage values, except differential voltage, are with respect to network ground terminal.

3. Typical values represent the most likely parametric norm.

4. All limits are guaranteed by testing or statistical analysis.

5. Input current must be limited by a resistor in series with the inputs.



■ 5V AC ELECTRICAL CHARACTERISTICS (Note 1)

 $(V^+=5.0V, V^-=0V, V_{CM}=V_0=V^+/2 \text{ and } R_L > 1M\Omega \text{ to } V^+/2, T_C=25^{\circ}C, \text{ unless otherwise specified})$

PARAMETER	SYMBOL	TEST CONDITIONS	MIN	TYP	МАХ	UNIT
	OTWIDOL	TEST SONDITIONS	(Note 3)	(Note 2)		UNIT
Slew Rate	SR	$\pm 4V @ V_s = \pm 6V, R_s > 1k\Omega$	5	14		V/µs
Gain-Bandwidth Product	GBW	f = 20kHz	7	10		MHz
Phase Margin	φm	R _L = 10k		33		Deg
Amp-to-Amp Isolation		R _L = 10k		10		dB
Input-Referred Voltage Noise	en	f =1kHz		27		nV/√Hz
Input-Referred Current Noise	i _n	f =1kHz		0.18		pA/√Hz

Notes: 1. Electrical Table values apply only for factory testing conditions at the temperature indicated. Factory testing conditions result in very limited self-heating of the device such that $T_J=T_A$. No guarantee of parametric performance is indicated in the electrical tables under conditions of the internal self heating where $T_J > T_A$.

2. Typical values represent the most likely parametric norm.

3. All limits are guaranteed by testing or statistical analysis.

■ 2.7V DC ELECTRICAL CHARACTERISTICS (Note 1)

 $(V^+=2.7V, V=0V, V_{CM}=V_0=V^+/2 \text{ and } R_L > 1M\Omega \text{ to } V^+/2, T_c=25^{\circ}C, \text{ unless otherwise specified})$

PARAMETER	SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT
	01111B0E		(Note 3)	(Note 2)	(Note 3)	01111
Input Offset Voltage	Vos			0.12	12	mV
Input Bias Current	IB	0V ≤ VCM ≤ 2.7V		90		nA
Input Offset Current	los			2.8		nA
Input Resistance, C _M	R _{IN}			134		MΩ
Common-Mode Rejection Ratio	CMRR	0V ≤ V _{CM} ≤2.7V		82		dB
Power Supply Rejection Ratio	PSRR	±1.35V ≤ V + ≤ ±12V		80		dB
Input Common-Mode Voltage Range	V _{CM}		0		2.7	V
Large Signal Voltage Gain	Av	R∟=10k		100		V/mV
Output Output	V _{OH}	R∟=100kΩ	2.25	2.66		V
Output Swing	V _{OL}	R _L =100kΩ		0.03	0.112	V
Supply Current	ls	Per Amplifier		250		μA

Notes: 1. Electrical Table values apply only for factory testing conditions at the temperature indicated. Factory testing conditions result in very limited self-heating of the device such that $T_J=T_A$. No guarantee of parametric performance is indicated in the electrical tables under conditions of the internal self heating where $T_J > T_A$.

- 2. Typical values represent the most likely parametric norm.
- 3. All limits are guaranteed by testing or statistical analysis.

■ 2.7V AC ELECTRICAL CHARACTERISTICS (Note 1)

 $(V^+=2.7V, V^=0V, V_{CM}=V_0=V^+/2 \text{ and } R_L > 1M\Omega \text{ to } V^+/2, T_C=25^{\circ}C, \text{ unless otherwise specified})$

PARAMETER	SYMBOL	TEST CONDITIONS	MIN (Note 3)	TYP (Note 2)	MAX	UNIT
Gain-Bandwidth Product	GBW	R _L = 10k, f = 20 kHz		7		MHz
Phase Margin	φ _m	R _L = 10k		23		Deg
Gain Margin	G _m			12		dB

Notes: 1. Electrical Table values apply only for factory testing conditions at the temperature indicated. Factory testing conditions result in very limited self-heating of the device such that $T_J=T_A$. No guarantee of parametric performance is indicated in the electrical tables under conditions of the internal self heating where $T_J > T_A$.

2. Typical values represent the most likely parametric norm.

3. All limits are guaranteed by testing or statistical analysis.



24V ELECTRICAL CHARACTERISTICS (Note 1)

 $(V^+=24V, V^-=0V, V_{CM}=V_0=V^+/2 \text{ and } R_L > 1M\Omega \text{ to } V^+/2, T_C=25^{\circ}C, \text{ unless otherwise specified})$

			/			
PARAMETER	SYMBOL	TEST CONDITIONS	MIN (Note 3)	TYP (Note 2)	MAX (Note 3)	UNIT
Input Offset Voltage	Vos			1.7	9.0	mV
Input Bias Current	Ι _Β			125		nA
Input Offset Current	I _{OS}			4.8		nA
Input Resistance, C _M	R _{IN}			210		MΩ
Common-Mode Rejection Ratio	CMRR	$0V \le V_{CM} \le 24V$		80		dB
Power Supply Rejection Ratio	PSRR	2.7V ≤ V ⁺ ≤ 24V		82		dB
Input Common-Mode Voltage Range	V _{CM}		0	-0.25~ 24.25	24	V
Large Signal Voltage Gain	Av	R _L =10k		102		V/mV
Output Quing	V _{OH}	R _L =10kΩ	23.8	23.86		V
Output Swing	V _{OL}	R _L =10kΩ		0.075	0.15	V
Supply Current	ls	Per Amplifier		390	490	μA
Gain-Bandwidth Product	GBW	R _L = 10k, f = 20 kHz		11		MHz

Notes: 1. Electrical Table values apply only for factory testing conditions at the temperature indicated. Factory testing conditions result in very limited self-heating of the device such that T_J=T_A. No guarantee of parametric performance is indicated in the electrical tables under conditions of the internal self heating where T_J > T_A.

2. Typical values represent the most likely parametric norm.

3. All limits are guaranteed by testing or statistical analysis.

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